Power MOSFET N-Channel ChipFET™

5.2 Amps, 20 Volts

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space

Applications

Power Management in Portable and Battery–Powered Products; i.e.,
 Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V _{DS}	20		V
Gate-Source Voltage	V _{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1.) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	I _D	±7.2 ±5.2	±5.2 ±3.8	А
Pulsed Drain Current	I _{DM}	±20		Α
Continuous Source Current (Diode Conduction) (Note 1.)	I _S	2.1	1.1	А
Maximum Power Dissipation (Note 1.) T _A = 25°C T _A = 85°C	P _D	2.5 1.3	1.3 0.7	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	–55 to	+150	°C

1. Surface Mounted on 1" x 1" FR4 Board.

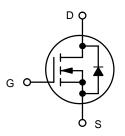


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5.2 AMPS 20 VOLTS

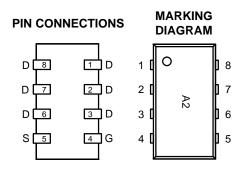
 $R_{DS(on)} = 30 \text{ m}\Omega$



N-Channel MOSFET



ChipFET CASE 1206A STYLE 1



A2 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping		
NTHS5404T1	ChipFET	3000/Tape & Reel		

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
$\label{eq:maximum Junction-to-Ambient (Note 2.)} $t \leq 5 \mbox{ sec} $$ Steady State $$$	R _{thJA}	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R_{thJF}	15	20	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static			•	•	•	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	_	_	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	_	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V	-	-	1.0	μΑ
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	_	-	5.0	
On-State Drain Current (Note 3.)	I _{D(on)}	$V_{DS} \ge 5.0 \text{ V}, V_{GS} = 4.5 \text{ V}$	20	_	_	Α
Drain-Source On-State Resistance (Note 3.)	r _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 5.2 \text{ A}$	-	0.025	0.030	Ω
		$V_{GS} = 2.5 \text{ V}, I_D = 4.3 \text{ A}$	_	0.038	0.045	
Forward Transconductance (Note 3.)	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 5.2 \text{ A}$	-	20	-	S
Diode Forward Voltage (Note 3.)	V_{SD}	I _S = 1.1 A, V _{GS} = 0 V	-	0.8	1.2	V
Dynamic (Note 4.)						
Total Gate Charge	Qg		-	12	18	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$ $I_{D} = 5.2 \text{ A}$	-	2.4	_	
Gate-Drain Charge	Q_{gd}		-	3.2	_	
Turn-On Delay Time	t _{d(on)}		_	20	30	ns
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_L = 10 \Omega$	-	40	60	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, V_{GEN} = 4.5 \text{ V},$ $R_G = 6 \Omega$	_	40	60	
Fall Time	t _f		_	15	23	
Source-Drain Reverse Recovery Time	t _{rr}	I _F = 1.1 A, di/dt = 100 A/μs	_	30	60	1

- Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
- 4. Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

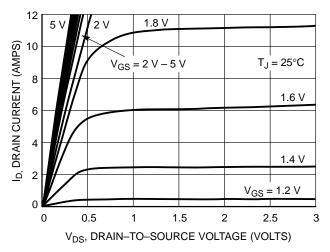


Figure 1. On-Region Characteristics

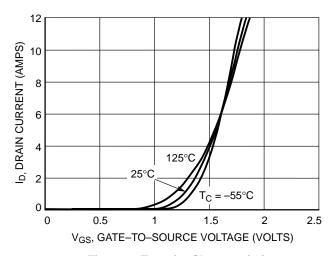


Figure 2. Transfer Characteristics

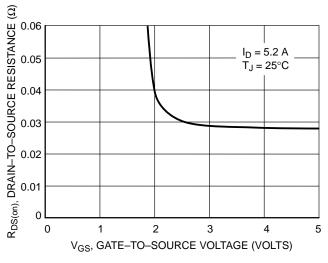


Figure 3. On–Resistance versus Gate–to–Source Voltage

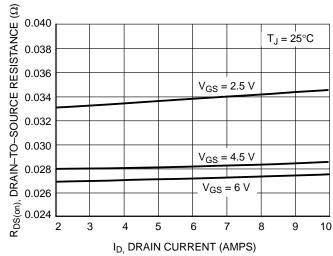


Figure 4. On–Resistance versus Drain Current and Gate Voltage

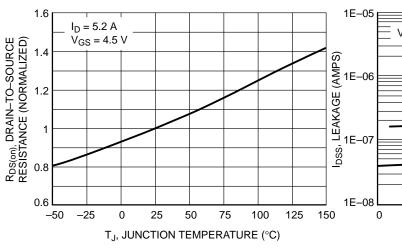


Figure 5. On–Resistance Variation with Temperature

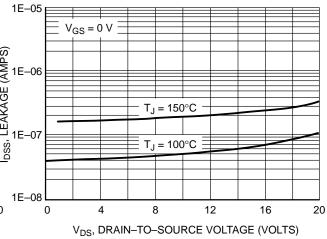
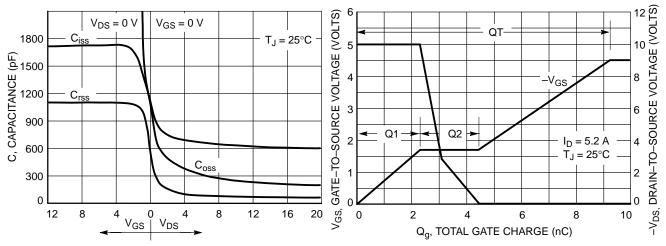


Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

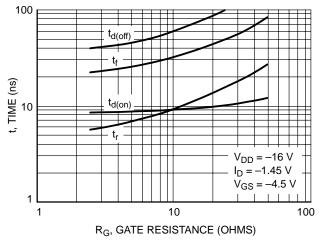


Figure 9. Resistive Switching Time Variation versus Gate Resistance

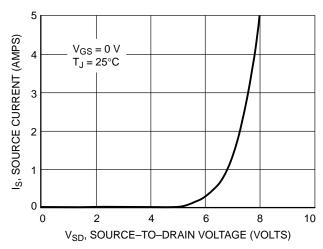


Figure 10. Diode Forward Voltage versus Current

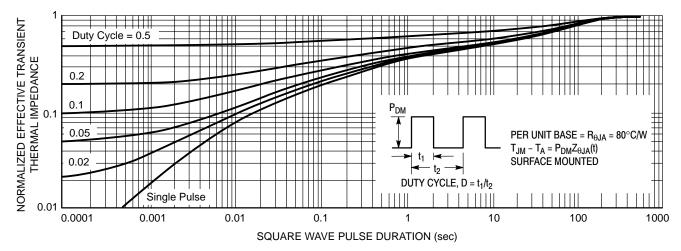


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

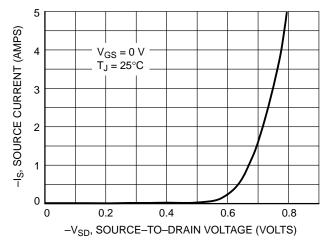
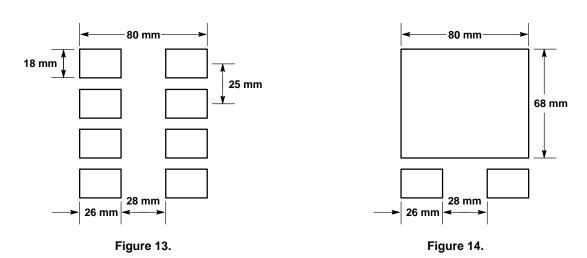


Figure 12. Diode Forward Voltage versus

Current



BASIC PAD PATTERNS

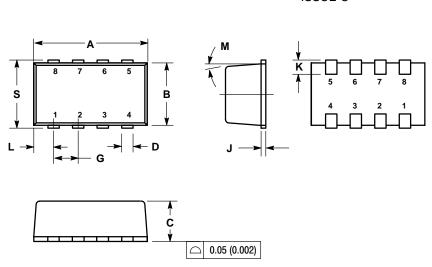
The basic pad layout with dimensions is shown in Figure 13. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 14 improves the thermal area of the drain connections (pins 1, 2, 3, 6, 7, 8) while remaining within the

confines of the basic footprint. The drain copper area is 0.0054 sq. in. (or 3.51 sq. mm). This will assist the power dissipation path away from the device (through the copper leadframe) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.

PACKAGE DIMENSIONS

ChipFET™ CASE 1206A-03 ISSUE C



NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: MILLIMETER.

 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.

 4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.

 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.

- MINENSIONS A AND B EXCLOSIVE OF WOLD GROUNDS.
 NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
٦	0.55 BSC		0.022 BSC		
M	5°	5° NOM		NOM	
S	1.80	2.00	0.072	0.080	

STYLE 1:
PIN 1. DRAIN
2. DRAIN
3. DRAIN
4. GATE
5. SOURCE
6. DRAIN
7. DRAIN
8. DRAIN

Notes

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